Search Notes

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						No.

10/706,642 Examiner

Jaworski Francis J.

Applicant(s)/Patent under Reexamination

TANAKA, KAZUE

Art Unit

3768

SEARCHED					
Class	Subclass	Date	Examiner		
601	2-4	12/3/2007	FJJ		
606	167-171				
604	22				
702	65-66				
	75-77				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
606	169	12/3/2007	FJJ		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
PLL or (phase\$1lock\$3) or sweep or swept and (vibrat\$5 or ultraso\$9), tool or instrument or probe	12/3/2007	FJJ	